

<b>LIST OF REFERENCES CITED BY APPLICANT</b> (Use several sheets if necessary)					ATTY DOCKET NO. <b>60937-194-US</b> (formerly 8317-194-999)		APPLICATION NO <b>10/360,300</b>	
					APPLICANT <b>Wai Mun Lee</b>			
					FILING DATE <b>07/30/03</b>		GROUP <b>1751</b>	
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
ND	Re. 30,714	8/1981	Harriman et al.	510	176			
ND	Re. 30,796	11/1981	Lesinski	510	176			
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ND	4,078,102	3/1978	Bendz et al.	422	16			
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ND	4,155,866	5/1979	Berkenblit et al.	430	329			
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ND	4,187,140	2/1980	Berkenblit et al.	430	357			
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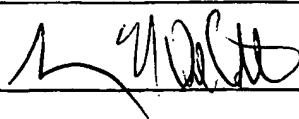
## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
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## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

10	World Patent Index 87-077755 re SU-A-1244211
10	Material Safety Data Sheet - 3 pages
10	Material Safety Data Sheet, Experimental Stripper, WMX-225 (1 sheet)
10	Material Safety Data Sheet, Experimental Stripper, WMX-230 (1 sheet)
10	"Reactions of Catechol," Crown Zellerbach Corp., Chemical Products Division, Camas, Washington 98607 (pp. 1-33 w/Cover Sheet and Table to Contents)
10	Pai, et al., "Metal Corrosion in Wet Resist Stripping Process," Microelectronic Mfg. and Testing, Feb. 1990, pp. 37-39.

EXAMINER



DATE CONSIDERED

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.